

1700V 900mΩ Silicon Carbide Power MOSFET N-Channel Enhancement Mode

#### **Features**

- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- 12V...15V / 0V  $V_{\rm GS}$  compatible with most flyback controllers
- Ultra-low drain-gate capacitance
- Halogen free, RoHS compliant
- Automotive qualified (AEC-Q101) and PPAP capable

#### **Benefits**

- Smooth switching waveforms
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Increases system switching frequency
- Increases system reliability

### **Typical Applications**

- Auxillary power supplies
- Switch Mode Power Supplies

#### **Package**



**Orderable** 









		Marking	
So	ower urce ,4,5,6,7)	JULIOMOTUA	30

High-Voltage capacitive loads	Part Number	Раскаде	Marking
	E3M0900170J-TR	T0-263-7L	E3M0900170J

#### **Key Parameters**

Parameter	Sym- bol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V <sub>DS</sub>			1700		T <sub>c</sub> = 25°C	
Maximum Gate - Source Voltage (Transient)	V <sub>GS(max)</sub>	-8		+19		Transient	
Operational Turn-On Gate-Source Voltage	V <sub>GS op</sub>		+12+15		V		
Operational Turn-Off Gate-Source Voltage	V <sub>GS op</sub>		-40			Static	
	_			4.4		$V_{GS} = 15 \text{ V}, T_{C} = 25 \text{ °C}, T_{J} \le 175 \text{ °C}$	Note 2
DC Continuous Drain Current	l <sub>D</sub>			3.3	A	$V_{GS} = 15 \text{ V}, T_{C} = 100 \text{ °C}, T_{J} \le 175 \text{ °C}$	
Pulsed Drain Current	I <sub>DM</sub>			15		$t_{Pmax}$ limited by $T_{jmax}$ $V_{GS} = 15V, T_{C} = 25 °C$	Fig. 22
Power Dissipation	P <sub>D</sub>			41	W	$T_c = 25^{\circ} C, T_J = 175^{\circ} C$	Fig. 20
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>			-55 to +175	°C		
Solder Temperature	T <sub>L</sub>			260			

Note (1): Review application Note PRD-04814 for additional details

Note (2): Verified by design

### **Electrical Characteristics** (T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1700			٧	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA	
		1.8	3.1	4.2	٧	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.55 mA	
$V_{\text{GS(th)}}$	Gate Threshold Voltage		2.6		٧	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.55 mA, T <sub>J</sub> = 175°C	Fig. 11
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μA	V <sub>DS</sub> = 1700 V, V <sub>GS</sub> = 0 V	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	V <sub>GS</sub> = 15 V, V <sub>DS</sub> = 0 V	
D			900	1250		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 1.99 A	Fig. 4,
R <sub>DS(on)</sub>	Drain-Source On-State Resistance		1938		mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 1.99 A, T <sub>J</sub> = 175°C	5, 6
	Transconductance		1		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 1.99 A	Fig. 7
<b>G</b> fs	Transconductance		1		3	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 1.99 A, T <sub>J</sub> = 175°C	Fig. 7
C <sub>iss</sub>	Input Capacitance		202				Fig. 17,
$C_{\text{oss}}$	Output Capacitance		8		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 1200 \text{ V}$	
$C_{rss}$	Reverse Transfer Capacitance		1.4			F = 100 kHz	
E <sub>oss</sub>	C <sub>oss</sub> Stored Energy		8		μJ	Vac = 25 mV	Fig. 16
$C_{\text{o(er)}}$	Effective Output Capacitance (Energy Related)		10		pF		Note: 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		13		pF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0V to 1200V	
Eon	Turn-On Switching Energy (External Diode)		128			V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = -4 V/15 V, I <sub>D</sub> = 1.99 A,	
E <sub>OFF</sub>	Turn Off Switching Energy (External Diode)		13		μJ	$R_{G(ext)} = 2.5 \Omega$ , L= 1707 $\mu$ H, $T_J = 175^{\circ}$ C FWD = External SiC DIODE	Fig. 26, 28
t <sub>d(on)</sub>	Turn-On Delay Time		20			V <sub>DD</sub> = 1200 V, V <sub>GS</sub> = -4 V/15 V	Fig. 27,
t <sub>r</sub>	Rise Time		16			$I_D = 1.99 \text{ A, } R_{G(ext)} = 2.5 \Omega, Tj=175^{\circ}\text{C},$	
$t_{\text{d(off)}}$	Turn-Off Delay Time		20		ns	L=1707 µH Timing relative to V <sub>DS</sub>	28
t <sub>f</sub>	Fall Time		42			Inductive load	
R <sub>G(int)</sub>	Internal Gate Resistance		31		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV	
$Q_{gs}$	Gate to Source Charge		4			V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = -4 V/15 V	
$Q_{\text{gd}}$	Gate to Drain Charge		2		nC	I <sub>D</sub> = 1.99 A	Fig. 12
Qg	Total Gate Charge		8			Per IEC60747-8-4 pg 21	

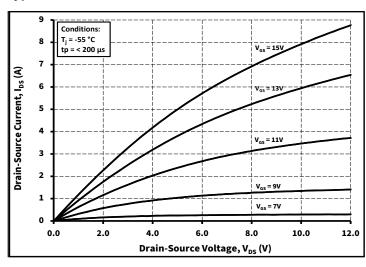
Note (3):  $C_{\circ(er)}$ , a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 1200V  $C_{\circ(tr)}$ , a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 1200V

# **Reverse Diode Characteristics** (T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
.,	D: 1.5	4.7		٧	$V_{GS} = -4 \text{ V, } I_{SD} = 1 \text{ A, } T_{J} = 25 \text{ °C}$	Fig. 8,
$V_{SD}$	Diode Forward Voltage	4.2		٧	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 1 A, T <sub>J</sub> = 175 °C	9, 10
Is	Continuous Diode Forward Current	6		А	V <sub>GS</sub> = -4 V, T <sub>C</sub> = 25°C	
I <sub>SM</sub>	Diode pulse Current		15	А	$V_{GS}$ = -4 V, pulse width $t_p$ limited by $T_{jmax}$	
t <sub>rr</sub>	Reverse Recover time	22		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	50		nC	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 1.99 A, V <sub>R</sub> = 1200 V dif/dt = 3710 A/μs, Τ <sub>ι</sub> = 25 °C	
Irrm	Peak Reverse Recovery Current	5		А		
t <sub>rr</sub>	Reverse Recover time	28		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	46		nC	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 1.99 A, V <sub>R</sub> = 1200 V dif/dt = 1030 A/μs, Τ <sub>ι</sub> = 25 °C	
Irrm	Peak Reverse Recovery Current	3		А		

### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
ReJc	Thermal Resistance from Junction to Case	3.0	3.6	°C/W		Fig. 21



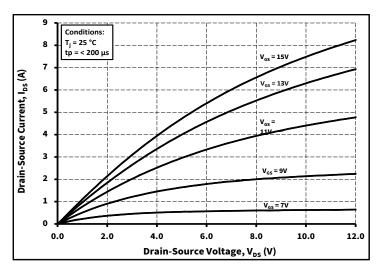
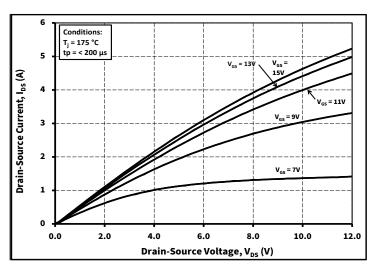


Figure 1. Output Characteristics T<sub>J</sub> = -55 °C

Figure 2. Output Characteristics  $T_J = 25$  °C



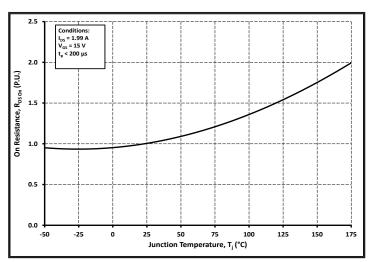
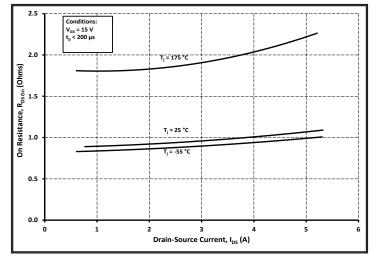


Figure 3. Output Characteristics T<sub>J</sub> = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



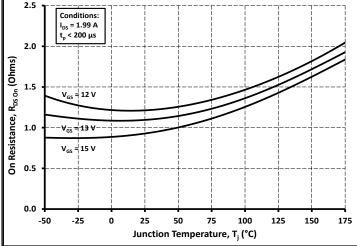
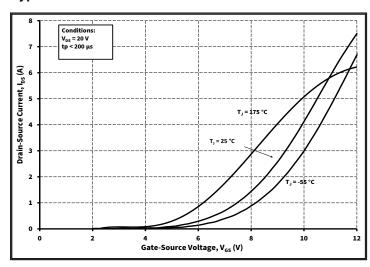


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage



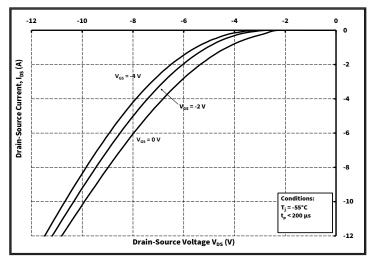
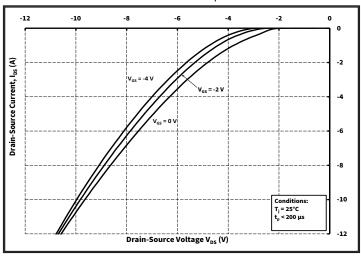


Figure 7. Transfer Characteristic for Various Junction Temperatures

Figure 8. Body Diode Characteristic at -55 °C



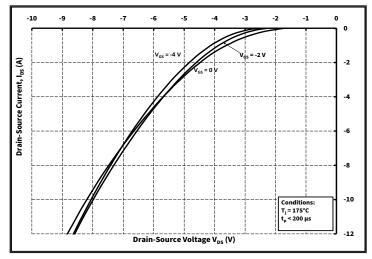
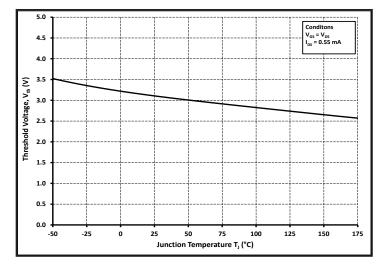


Figure 9. Body Diode Characteristic at 25 °C

Figure 10. Body Diode Characteristic at 175 °C



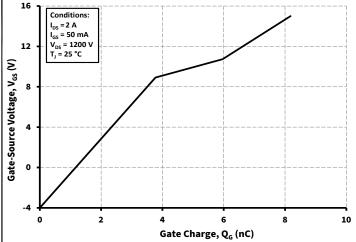
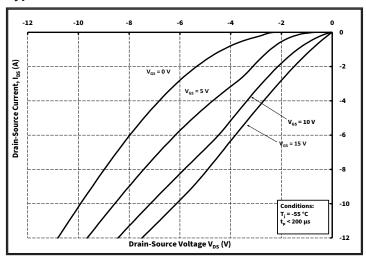
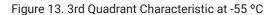


Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristics





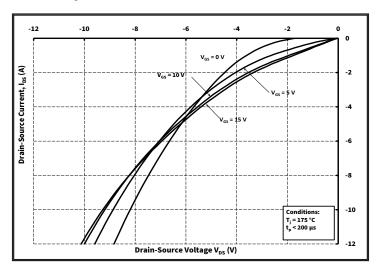


Figure 15. 3rd Quadrant Characteristic at 175 °C

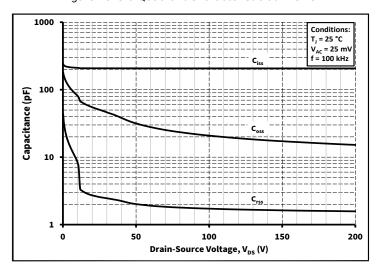


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

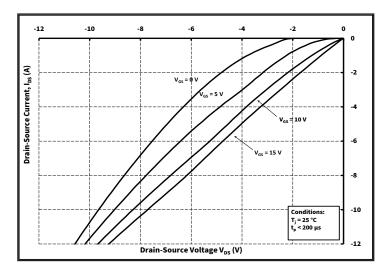


Figure 14. 3rd Quadrant Characteristic at 25 °C

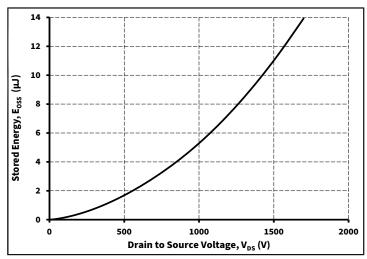


Figure 16. Output Capacitor Stored Energy

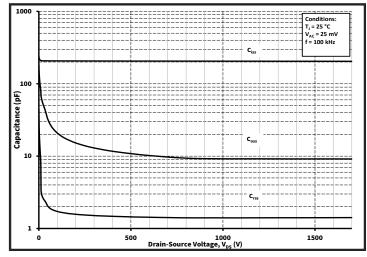


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1700V)

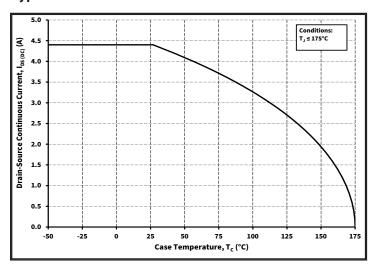


Figure 19. Continuous Drain Current Derating vs.

Case Temperature

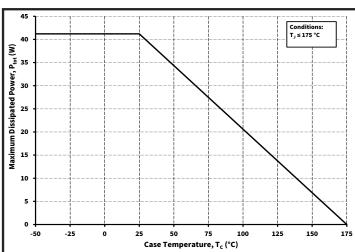


Figure 20. Maximum Power Dissipation Derating vs.

Case Temperature

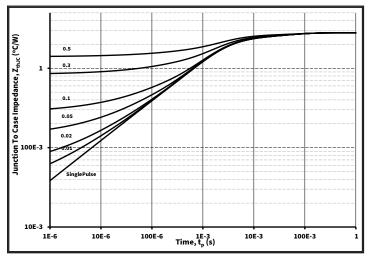


Figure 21. Transient Thermal Impedance (Junction - Case)

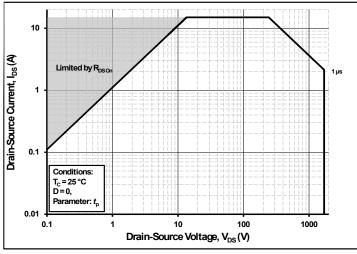


Figure 22. Safe Operating Area

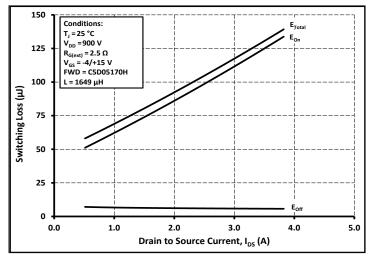


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}$  = 900V)

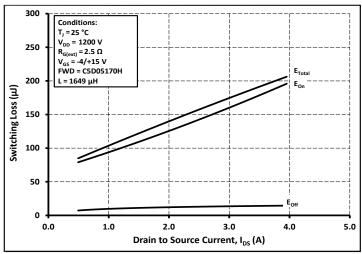


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{\rm DD}$  = 1200V)

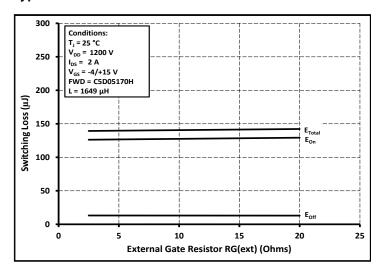


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$ 

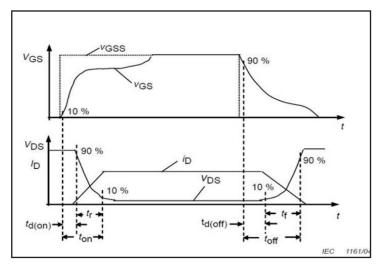


Figure 27. Switching Times Definition

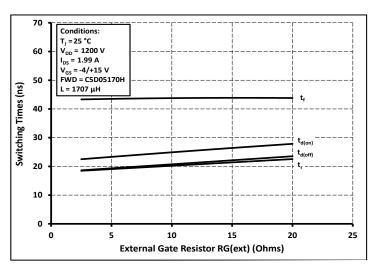


Figure 26. Switching Times vs.  $R_{G(ext)}$ 

### **Test Circuit Schematic**

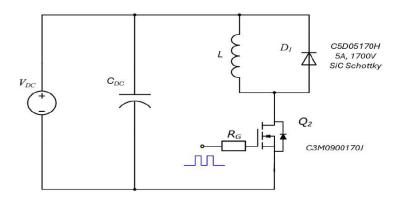
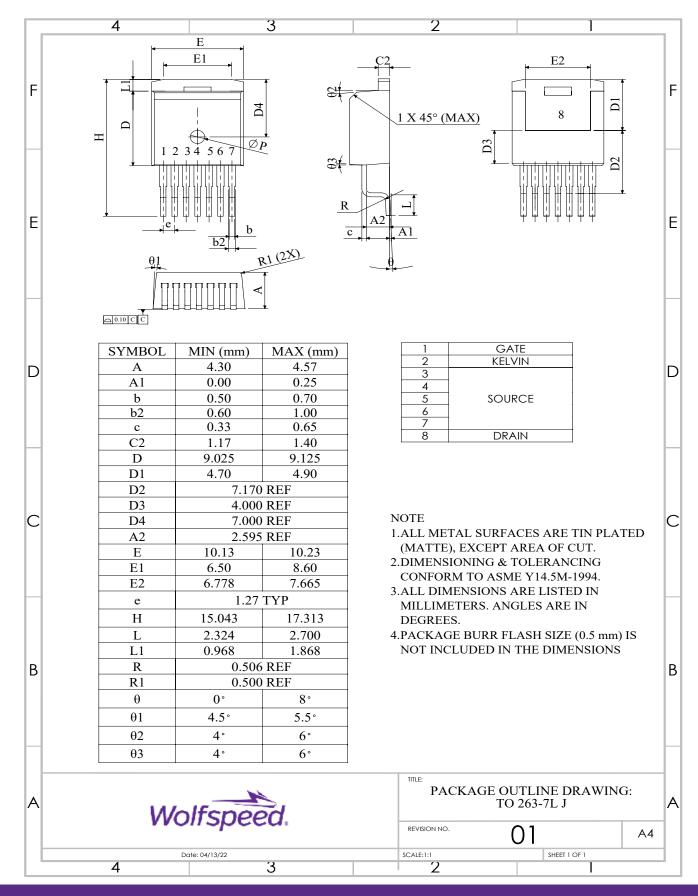


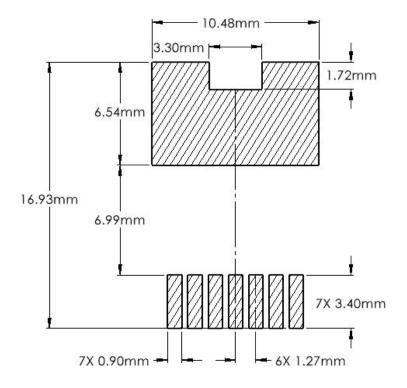
Figure 28. Clamped Inductive Switching Waveform Test Circuit

#### **Package Dimensions**



### Recommended Solder Pad Lavout

All dimensions in mm



# Revision history

Document Version	Date of release	Descriptiion of changes
1	March - 2025	Initial Release

#### Notes & Disclaimer

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